

UFS Series N-Channel IGBTs

40 A, 600 V

HGTG20N60B3

The HGTG20N60B3 is a Generation III MOS gated high voltage switching devices combining the best features of MOSFETs and bipolar transistors. These devices have the high input impedance of a MOSFET and the low on-state conduction loss of a bipolar transistor. The much lower on-state voltage drop varies only moderately between 25°C and 150°C.

The IGBT is ideal for many high voltage switching applications operating at moderate frequencies where low conduction losses are essential, such as: AC and DC motor controls, power supplies and drivers for solenoids, relays and contactors.

Formerly developmental type TA49050.

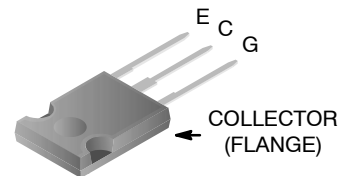
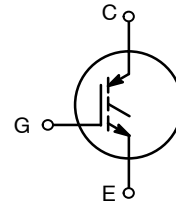
Features

- 40 A, 600 V at $T_C = 25^\circ\text{C}$
- 600 V Switching SOA Capability
- Typical Fall Time 140 ns at 150°C
- Short Circuit Rated
- Low Conduction Loss
- Related Literature
 - ◆ TB334 “Guidelines for Soldering Surface Mount Components to PC Boards”
- This is a Pb-Free Device



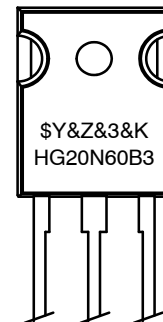
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TO-247-3LD SHORT LEAD
CASE 340CK
JEDEC STYLE

MARKING DIAGRAM



\$Y = ON Semiconductor Logo
&Z = Assembly Plant Code
&3 = Numeric Date Code
&K = Lot Code
HG20N60B3 = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

HGTG20N60B3

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise specified)

Parameter	Symbol	HGTG20N60B3	Unit
Collector to Emitter Voltage	BV _{CES}	600	V
Collector to Gate Voltage, R _{GE} = 1 MΩ	BV _{CGR}	600	A
Collector Current Continuous At T _C = 25°C At T _C = 110°C	I _{C25} I _{C110}	40 20	A A
Collector Current Pulsed (Note 1)	I _{CM}	160	A
Gate to Emitter Voltage Continuous	V _{GES}	±20	V
Gate to Emitter Voltage Pulsed	V _{GEM}	±30	V
Switching Safe Operating Area at T _C = 150°C	SSOA	30 A at 600 V	
Power Dissipation Total at T _C = 25°C	P _D	165	W
Power Dissipation Derating T _C > 25°C		1.32	W/°C
Operating and Storage Junction Temperature Range	T _J , T _{STG}	-40 to 150	°C
Maximum Temperature for Soldering Leads at 0.063 in (1.6 mm) from Case for 10 s Package Body for 10 s, see Tech Brief 334	T _L T _{pkg}	300 260	°C °C
Short Circuit Withstand Time (Note 2) at V _{GE} = 15 V	t _{SC}	4	μs
Short Circuit Withstand Time (Note 2) at V _{GE} = 10 V	t _{SC}	10	μs

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. V_{CE} = 360 V, T_C = 125°C, R_G = 25 Ω

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit	
Collector to Emitter Breakdown Voltage	BV _{CES}	I _C = 250 μA, V _{GE} = 0 V	600	-	-	V	
Emitter to Collector Breakdown Voltage	BV _{ECS}	I _C = 10 mA, V _{GE} = 0 V	20	-	-	V	
Collector to Emitter Leakage Current	I _{CES}	V _{CE} = BV _{CES}	T _C = 25°C	-	-	250	μA
			T _C = 150°C	-	-	1.0	mA
Collector to Emitter Saturation Voltage	V _{CE(SAT)}	I _C = I _{C110} , V _{GE} = 15 V	T _C = 25°C	-	1.8	2.0	V
			T _C = 150°C	-	2.1	2.5	V
Gate to Emitter Threshold Voltage	V _{GE(TH)}	I _C = 250 μA, V _{CE} = V _{GE}	3.0	5.0	6.0	V	
Gate to Emitter Leakage Current	I _{GES}	V _{GE} = ±20 V	-	-	±100	nA	
Switching SOA	SSOA	T _C = 150°C, V _{GE} = 15 V, R _G = 10 Ω, L = 45 μH	V _{CE} = 480 V	100	-	-	A
			V _{CE} = 600 V	30	-	-	A
Gate to Emitter Plateau Voltage	V _{GEP}	I _C = I _{C110} , V _{CE} = 0.5 BV _{CES}	-	8.0	-	V	
On-State Gate Charge	Q _{G(ON)}	I _C = I _{C110} , V _{CE} = 0.5 BV _{CES}	V _{GE} = 15 V	-	80	105	nC
			V _{GE} = 20 V	-	105	135	nC
Current Turn-On Delay Time	t _{d(ON)I}	T _J = 150°C, I _{CE} = I _{C110} , V _{CE} = 0.8 BV _{CES} , V _{GE} = 15 V, R _G = 10 Ω, L = 100 μH	-	25	-	ns	
Current Rise Time	t _{rl}		-	20	-	ns	
Current Turn-Off Delay Time	t _{d(OFF)I}		-	220	275	ns	
Current Fall Time	t _{fl}		-	140	175	ns	
Turn-On Energy	E _{ON}		-	475	-	μJ	
Turn-Off Energy (Note 3)	E _{OFF}		-	1050	-	μJ	
Thermal Resistance	R _{θJC}		-	-	0.76	-	°C/W

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Turn-Off Energy Loss (E_{OFF}) is defined as the integral of the instantaneous power loss starting at the trailing edge of the input pulse and ending at the point where the collector current equals zero (I_{CE} = 0 A). The HGTG20N60B3 was tested per JEDEC standard No. 24-1 Method for Measurement of Power Device Turn-Off Switching Loss. This test method produces the true total Turn-Off Energy Loss. Turn-On losses include diode losses.

HGTG20N60B3

TYPICAL PERFORMANCE CURVES

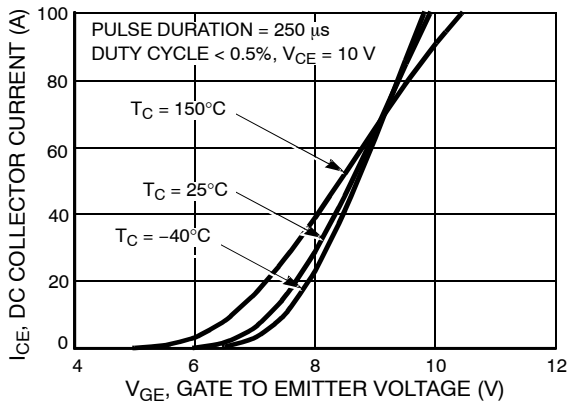


Figure 1. TRANSFER CHARACTERISTICS

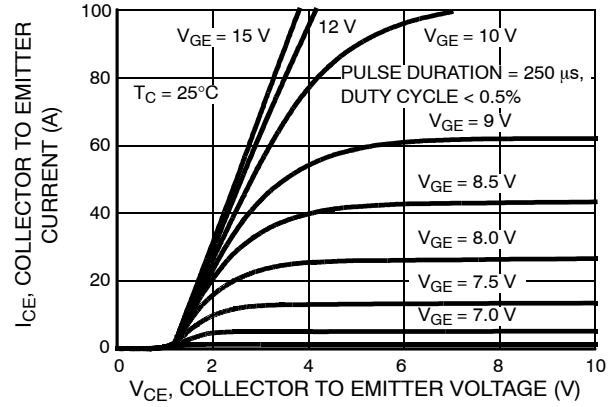


Figure 2. SATURATION CHARACTERISTICS

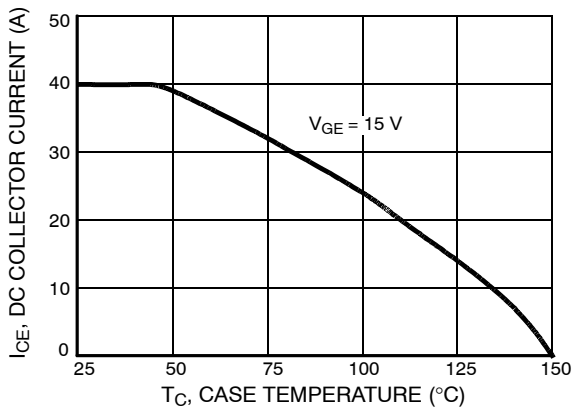


Figure 3. DC COLLECTOR CURRENT vs. CASE TEMPERATURE

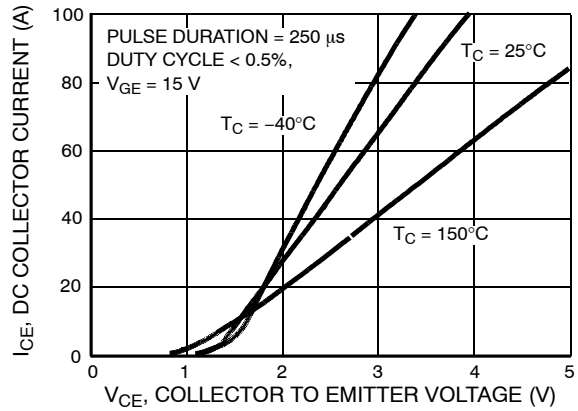


Figure 4. COLLECTOR TO EMITTER ON-STATE VOLTAGE

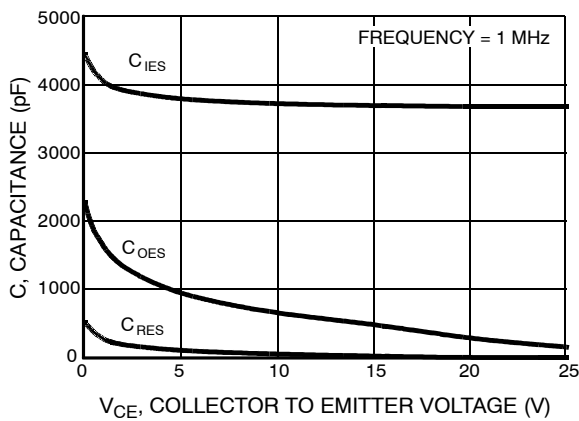


Figure 5. CAPACITANCE vs. COLLECTOR TO EMITTER VOLTAGE

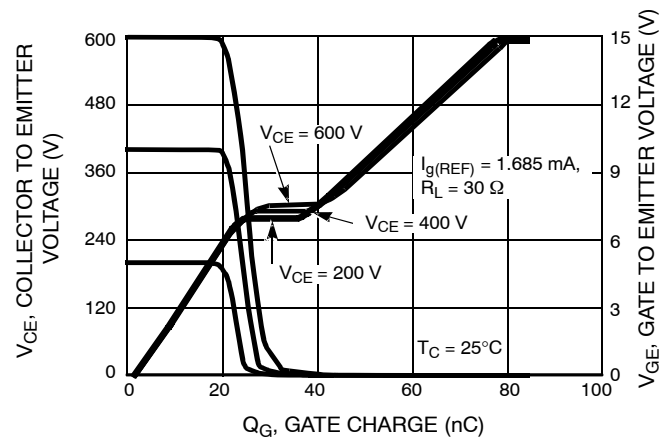


Figure 6. GATE CHARGE WAVEFORMS

HGTG20N60B3

TYPICAL PERFORMANCE CURVES (continued)

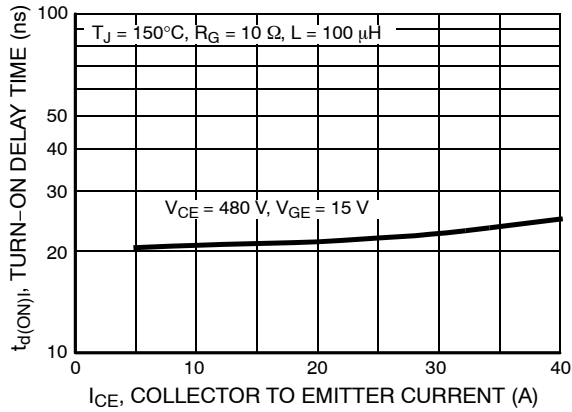


Figure 7. TURN-ON DELAY TIME vs. COLLECTOR TO EMITTER CURRENT

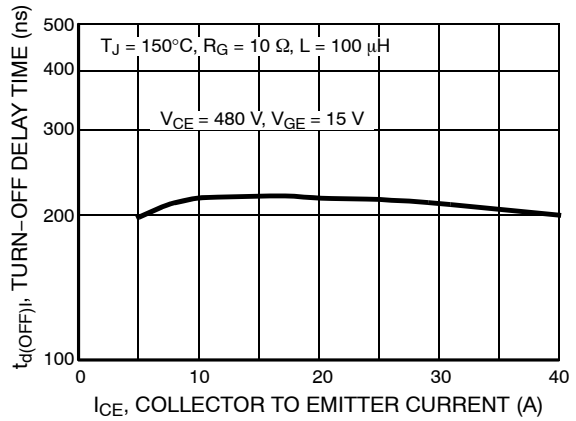


Figure 8. TURN-OFF DELAY TIME vs. COLLECTOR TO EMITTER CURRENT

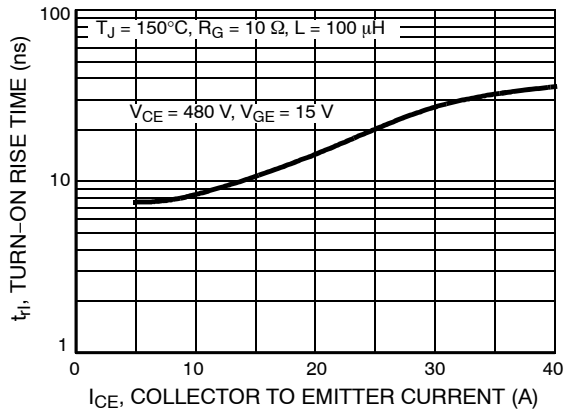


Figure 9. TURN-ON RISE TIME vs. COLLECTOR TO EMITTER CURRENT

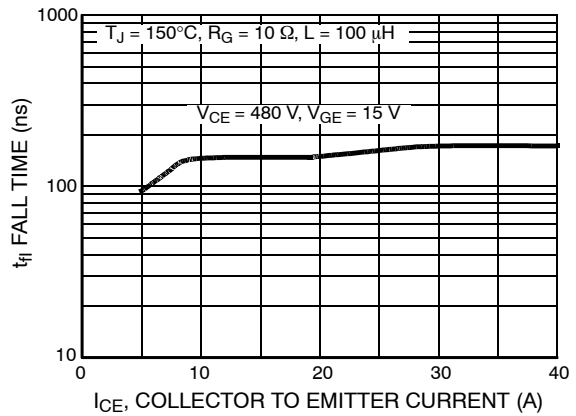


Figure 10. TURN-OFF FALL TIME vs. COLLECTOR TO EMITTER CURRENT

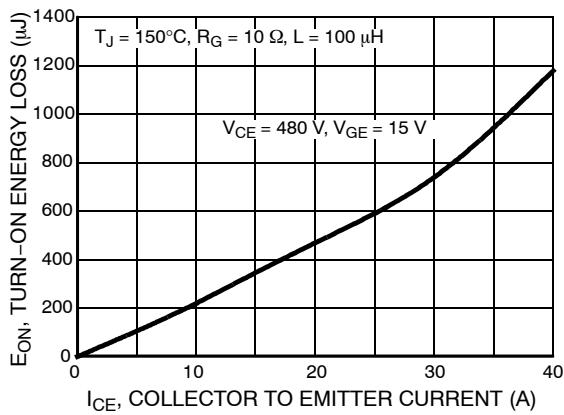


Figure 11. TURN-ON ENERGY LOSS vs. COLLECTOR TO EMITTER CURRENT

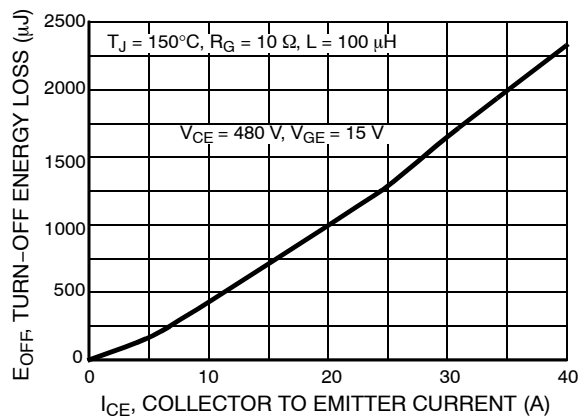


Figure 12. TURN-OFF ENERGY LOSS vs. COLLECTOR TO EMITTER CURRENT

HGTG20N60B3

TYPICAL PERFORMANCE CURVES (continued)

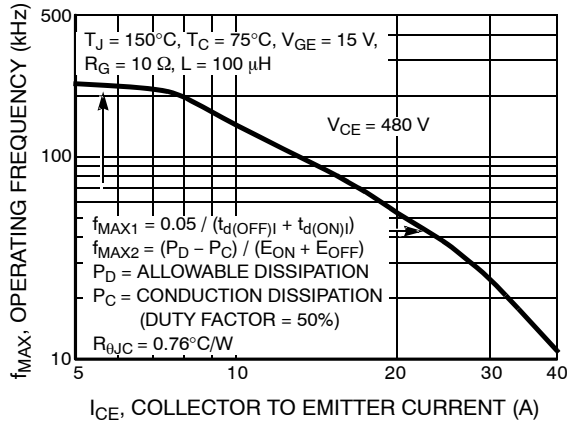


Figure 13. OPERATING FREQUENCY vs COLLECTOR TO EMITTER CURRENT

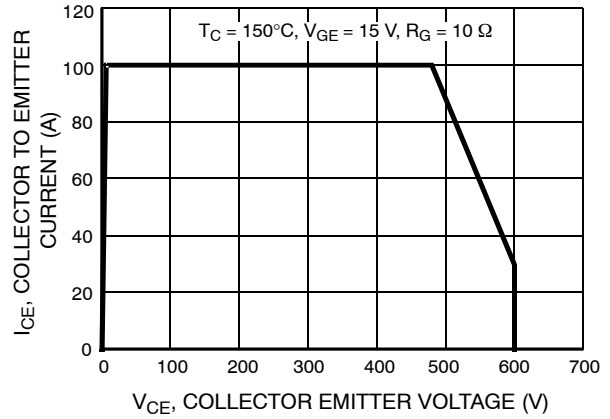


Figure 14. SWITCHING SAFE OPERATING AREA

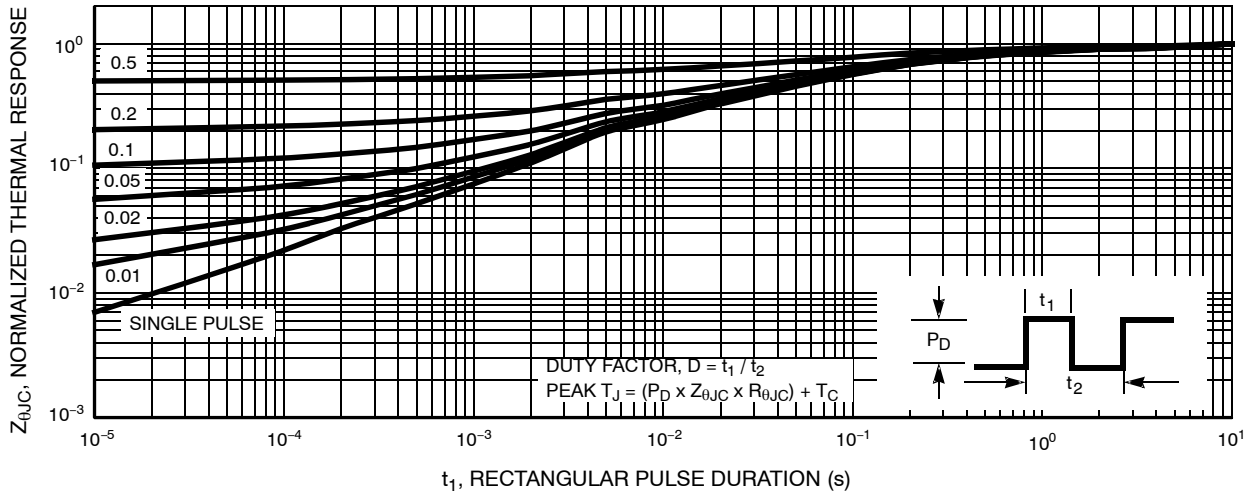


Figure 15. IGBT NORMALIZED TRANSIENT THERMAL RESPONSE, JUNCTION TO CASE

TEST CIRCUIT AND WAVEFORM

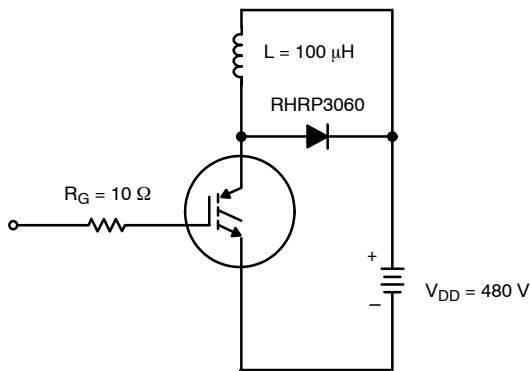


Figure 16. INDUCTIVE SWITCHING TEST CIRCUIT

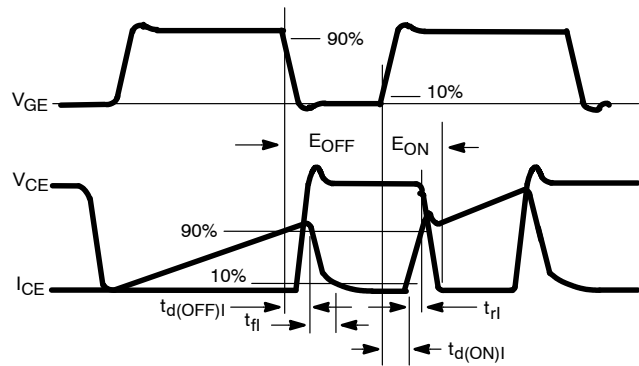


Figure 17. SWITCHING TEST WAVEFORMS

HANDLING PRECAUTIONS FOR IGBTs

Insulated Gate Bipolar Transistors are susceptible to gate-insulation damage by the electrostatic discharge of energy through the devices. When handling these devices, care should be exercised to assure that the static charge built in the handler’s body capacitance is not discharged through the device. With proper handling and application procedures, however, IGBTs are currently being extensively used in production by numerous equipment manufacturers in military, industrial and consumer applications, with virtually no damage problems due to electrostatic discharge. IGBTs can be handled safely if the following basic precautions are taken:

1. Prior to assembly into a circuit, all leads should be kept shorted together either by the use of metal shorting springs or by the insertion into conductive material such as ECCOSORB[™] LD26” or equivalent.
2. When devices are removed by hand from their carriers, the hand being used should be grounded by any suitable means – for example, with a metallic wristband.
3. Tips of soldering irons should be grounded.
4. Devices should never be inserted into or removed from circuits with power on.
5. *Gate Voltage Rating* – Never exceed the gate-voltage rating of V_{GEM}. Exceeding the rated V_{GE} can result in permanent damage to the oxide layer in the gate region.
6. *Gate Termination* – The gates of these devices are essentially capacitors. Circuits that leave the gate open– circuited or floating should be avoided. These conditions can result in turn-on of the device due to voltage buildup on the input capacitor due to leakage currents or pickup.
7. *Gate Protection* - These devices do not have an internal monolithic zener diode from gate to emitter. If gate protection is required an external zener is recommended.

OPERATING FREQUENCY INFORMATION

Operating frequency information for a typical device (Figure 13) is presented as a guide for estimating device performance for a specific application. Other typical frequency vs collector current (I_{CE}) plots are possible using the information shown for a typical unit in Figures 4, 7, 8, 11 and 12. The operating frequency plot (Figure 13) of a typical device shows f_{MAX1} or f_{MAX2} whichever is smaller at each point. The information is based on measurements of a typical device and is bounded by the maximum rated junction temperature.

f_{MAX1} is defined by $f_{MAX1} = 0.05 / (t_{d(OFF)I} + t_{d(ON)I})$. Deadtime (the denominator) has been arbitrarily held to 10% of the on– state time for a 50% duty factor. Other definitions are possible. t_{d(OFF)I} and t_{d(ON)I} are defined in Figure 17.

Device turn-off delay can establish an additional frequency limiting condition for an application other than T_{JM}. t_{d(OFF)I} is important when controlling output ripple under a lightly loaded condition.

f_{MAX2} is defined by $f_{MAX2} = (P_D - P_C) / (E_{OFF} + E_{ON})$. The allowable dissipation (P_D) is defined by $P_D = (T_{JM} - T_C) / R_{\theta JC}$. The sum of device switching and conduction losses must not exceed P_D. A 50% duty factor was used (Figure 13) and the conduction losses (P_C) are approximated by $P_C = (V_{CE} \times I_{CE}) / 2$.

E_{ON} and E_{OFF} are defined in the switching waveforms shown in Figure 17. E_{ON} is the integral of the instantaneous power loss (I_{CE} x V_{CE}) during turn-on and E_{OFF} is the integral of the instantaneous power loss (I_{CE} x V_{CE}) during turn-off. All tail losses are included in the calculation for E_{OFF}; i.e., the collector current equals zero (I_{CE} = 0).

ORDERING INFORMATION

Part Number	Package	Brand	Shipping
HGTG20N60B3	TO-247	HG20N60B3	450 Units / Tube

NOTE: When ordering, use the entire part number.



TO-247-3LD SHORT LEAD
CASE 340CK
ISSUE A

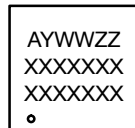
DATE 31 JAN 2019



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 - 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



- XXXX = Specific Device Code
- A = Assembly Location
- Y = Year
- WW = Work Week
- ZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	4.58	4.70	4.82
A1	2.20	2.40	2.60
A2	1.40	1.50	1.60
b	1.17	1.26	1.35
b2	1.53	1.65	1.77
b4	2.42	2.54	2.66
c	0.51	0.61	0.71
D	20.32	20.57	20.82
D1	13.08	~	~
D2	0.51	0.93	1.35
E	15.37	15.62	15.87
E1	12.81	~	~
E2	4.96	5.08	5.20
e	~	5.56	~
L	15.75	16.00	16.25
L1	3.69	3.81	3.93
ØP	3.51	3.58	3.65
ØP1	6.60	6.80	7.00
Q	5.34	5.46	5.58
S	5.34	5.46	5.58

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[IKFW60N65ES5XKSA1](#) [IMBG120R090M1HXTMA1](#) [IMBG120R220M1HXTMA1](#) [XD15H120CX1](#) [XD25H120CX0](#) [XP15PJS120CL1B1](#)
[IGW30N60H3FKSA1](#) [STGWA8M120DF3](#) [IGW08T120FKSA1](#) [IGW75N60H3FKSA1](#) [HGTG40N60B3](#) [FGH60N60SMD_F085](#)
[FGH75T65UPD](#) [STGWA15H120F2](#) [IKA10N60TXKSA1](#) [IHW20N120R5XKSA1](#) [RJH60D2DPP-M0#T2](#) [IKP20N60TXKSA1](#)
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